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Determination of light-independent shunt resistance in CIGS photovoltaic cells using a collection function-based model

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The shunt resistance R_{sh} is a critical parameter for photovoltaic cells designed for low light indoor applications because it negatively affects the open circuit voltage, fill factor, and conversion efficiency. Standard CIGS cells are known to have low R_{sh} and are therefore unpromising candidates for indoor energy sources. In this paper, we extend the original work of Virtuani *et al.* by determining the electrical specifications of many CIGS cells with copper contents $[Cu]/([Ga]+[In])$ as low as 0.33 and gallium contents between 0.28 and 0.81. First, the IV data are fitted by a standard single-diode electrical circuit model for each illumination, resulting in light-dependent parameters. Then we use a procedure based on a single data set of electrical variables, i.e. independent of light, corrected by the experimental collection function, which captures the light-dependent physical mechanisms. In this way, we are able to correctly reproduce the illuminance dependence of the electrical response of the PV cell over three orders of magnitude, in particular with a fixed value of the shunt resistance. The highest R_{sh} is obtained with a low copper composition of 0.5, regardless of the gallium rate.

Keywords: indoor photovoltaics, CIGS, shunt resistance, IV characteristics, collection function

I. INTRODUCTION

The Cu(In,Ga)Se₂-based photovoltaic (PV) cells are now a mature technology in solar energy conversion¹⁻³. Successive improvements over time, such as the three-stage deposition process or the alkali post-deposition treatment, have led to an optimized device structure that provides maximum conversion efficiency for the AM1.5 solar spectrum. In these cells, the CIGS absorber is close to stoichiometry with a ratio $[Cu]/([Ga]+[In]) \sim 0.9$ and an average gallium content of $[Ga]/([Ga]+[In]) \sim 0.35$.

The potential of CIGS photovoltaic cells for indoor applications has been poorly studied in the past, mainly because standard structures optimized for outdoor conditions have low shunt resistances. Indeed, the uneven CdS/CIGS interface and the presence of pinholes and grain boundaries in the absorber tend to favor shunting pathways⁴. The strong contribution of the current shunting the diode dominates under low light conditions, which is detrimental to the open circuit voltage, which decreases proportionally to the photocurrent. Indoor illuminance is generally less than 1000 lx, while the outdoor illuminance is of the order of 100 klx. As a consequence, standard CIGS cells at low illuminances are characterized by extremely low open circuit voltages, low fill factors and low conversion efficiencies, and thus negligible electrical powers. Virtuani *et al.*⁵⁻⁷ demonstrated that the shunt resistance can be significantly increased by reducing the copper content in the absorber alloy, while the thickness of the ZnO:Al and CdS layers does not play a role in the improvement. The authors focused on CIGS cells with a $[Ga]/([Ga]+[In])$ ratio, hereafter referred to as *GGI*, of

0.33. The *CGI* ratio, i.e. $[Cu]/([Ga]+[In])$, was between 0.59 and 0.89.

In the present work, the earlier study is expanded to investigate the electrical properties of CIGS thin films on wide copper and gallium composition windows, with $0.33 < CGI < 1$ and $0.28 < GGI < 0.81$. The IV characteristics of all the cells are measured as a function of the illuminance of a white LED over a range of three orders of magnitude. This complete data set allows the extraction of the light-dependent electrical specifications of the components that make up the single-diode PV cell model at each alloy composition. In a second step, we consider light-independent parameters, complemented by the collection function that includes all the light-dependent physical mechanisms⁸⁻¹¹. Our main result is the drastic increase of the shunt resistance by more than two orders of magnitude with the reduction of copper to $CGI = 0.45 - 0.5$, where R_{sh} is maximum, $\sim 100 \text{ k}\Omega \text{ cm}^2$, independent of the *GGI* ratio. It increases the open circuit voltage and results in a one thousand times higher maximum power compared to copper stoichiometric CIGS cells at very low illuminances.

II. CELL FABRICATION AND MEASUREMENTS

The photovoltaic cells studied are standard ZnO/CdS/CIGS/Mo heterostructures grown on soda-lime glass substrates. First, the molybdenum back contact is deposited by RF sputtering, following the technique optimized by Briot *et al.*¹². The CIGS absorber layer is grown on top by the co-evaporation of pure copper, indium, gallium and selenium. The deposition is performed in a single step run of 80 minutes with a constant atomic flux of all chemical species throughout the process. This step results in a 2 μm thick

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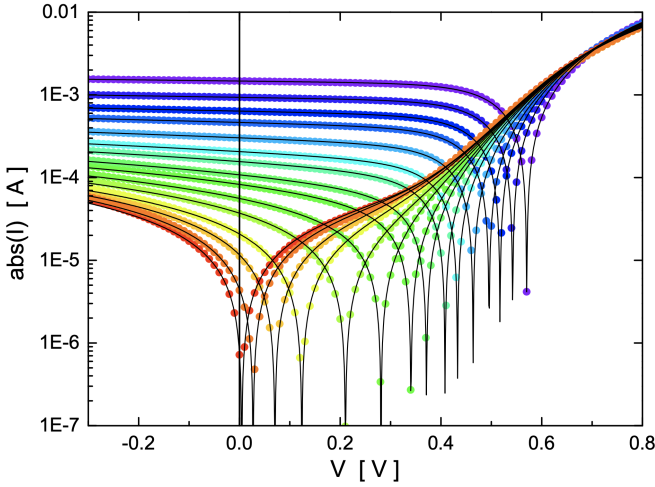


FIG. 1. Current-voltage characteristics measured in a CIGS cell with $GGI = 0.81$ and $CGI = 0.99$ as a function of the illuminance of a white LED in the range 50 lx to 60 klx. The dots are the experimental data and the solid lines are the fits by the single-diode model.

CIGS film for a standard cell. The n-type CdS layer is deposited in an ammonia solution consisting of thiourea and cadmium sulfate and the i-ZnO and Al-ZnO top windows are obtained by RF sputtering from *ad hoc* targets. Three batches of cells were grown, each defined by an almost constant gallium content, but different copper compositions in each series. The target values of the GGI ratio were 0.28, 0.64, and 0.81. The CGI ratio was reduced from ~ 1 for the high copper alloys to 0.4 for the low copper materials. The alloy compositions were tuned by acting on the relative rate of the partial pressures of the precursor beams during growth, allowed by a precise control of the temperature of the effusion cells. The growth of the absorber by a single-step protocol results in a layer with a relatively homogeneous alloy composition along the growth axis, in contrast to the composition gradient that occurs in three-step CIGS cells. The single-step approach, in which all elements are evaporated simultaneously, also makes it easier to control the chemical composition from high to low copper and/or gallium content. The compositions of all samples were measured by energy dispersive X-ray spectroscopy (EDS) by averaging over a sufficiently large rectangular area ($100 \times 100 \mu\text{m}^2$). The GGI and CGI given below are the measured values. Electrical specifications were obtained on $0.5 \times 0.5 \text{ cm}^2$ square cells, realized by mechanical scribing, with an indium top contact at the center. The raw values are plotted directly in the following graphs and are not scaled per unit area. The current vs voltage (IV) characteristics are measured with a Keithley 2401 sourcemeter at a fixed illuminance provided by a white LED. The illuminance dependence is performed by varying the LED supply current to cover nearly three orders of magnitude, from 50 lx to 60 klx. The white LED is a 5000 K Bridgelux

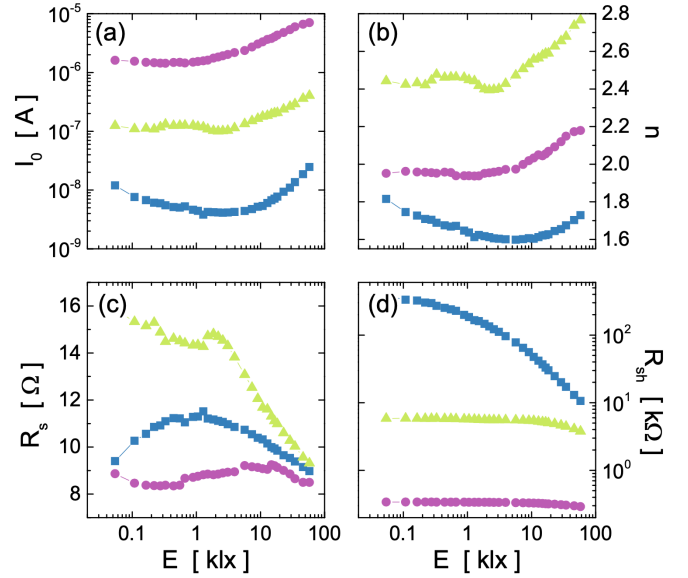


FIG. 2. (a, b, c, d) Fitting parameters of the single-diode electrical model, I_0 , n , R_s and R_{sh} respectively vs illuminance. The data of three CIGS cells are plotted with the following compositions: $GGI = 0.28$, $CGI = 0.94$ (purple dots), $GGI = 0.81$, $CGI = 0.99$ (green triangles) and $GGI = 0.28$, $CGI = 0.47$ (blue squares).

BXRE-50S and the illuminance is calibrated with a C.A 1110 Chauvin Arnoux luxmeter.

III. FITTING IV CURVES WITH LIGHT-DEPENDENT ELECTRICAL PARAMETERS

The illuminance dependence of the IV curves measured in the $GGI = 0.81$ and $CGI = 0.99$ cell is shown in Fig. 1, where the absolute value of the current is plotted. The vertical axis is on a logarithmic scale, allowing observation of three orders of magnitude of the photogenerated current from $1 \mu\text{A}$ to $\sim 1 \text{ mA}$ at $V = 0 \text{ V}$, indicated by the vertical line. The horizontal axis is linear because the open circuit voltage decreases gradually from 0.55 V to zero. Each IV curve is fitted with a classical single-diode electrical model consisting of a series resistance R_s and a shunt resistance R_{sh} in parallel with a diode, characterized by its saturation current I_0 and its ideality factor n . The fits are performed over a wide voltage range, from $V = -0.3 \text{ V}$ to 0.8 V , in order to accurately estimate both resistances R_{sh} and R_s , as shown by the good agreement of the solid lines in Figure 1. This large fitting window is even more indispensable at very low illuminances, when the photocurrent generating operation of the cell is greatly reduced for negligible positive voltages between zero and a very weak open-circuit voltage, V_{oc} .

The various parameters of the DC electrical circuit are plotted as a function of the LED illuminance, E , in Fig. 2(a-d) for three CIGS cells with different copper and gallium contents. These three cells were cho-

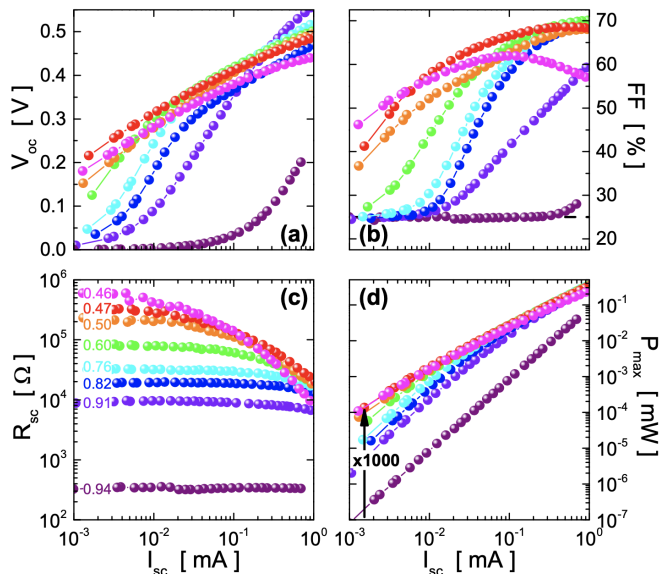


FIG. 3. (a), (b), (c) and (d) Open circuit voltage, fill factor, short circuit resistance and maximum power as a function of the short circuit current for 8 photovoltaic cells. The CIGS absorbers have an average GGI ratio of 0.28 and CGI ratios in the range 0.46 – 0.94, which are indicated in (c).

sen for their very different values of shunt resistance (see Fig.2(d)), ranging from a few 100 Ω to several k Ω . It is worth noting that there is no general trend for the light dependence of each parameter. For example, the reverse current and the ideality factor of the diode start to decrease when the illuminance is reduced from high intensities, but then they can saturate (dot and triangle series) or even increase again (square series) at low light levels. The illuminance dependence of the series resistance is also ambiguous, with a monotonic increase, a bell-shaped curve, or a quasi-constant value observed for the different cases. The shunt resistance in Fig. 2(d) tends to increase and then saturate as the light intensity decreases for all cells, but the amplitude of the R_{sh} variation differs from sample to sample. In fact, the ratio of the dark shunt resistance to that extracted under 60 klx is equal to 1.2 and 1.5 for the two samples with the lowest R_{sh} , but is greater than 35 for the device with the highest resistance. These different behaviors of the parameters vs E cannot be attributed to the limit of validity of the electrical model for certain samples or the fitting procedure, since all experimental data were fitted identically with equal agreement. Thus, the observed variations in electrical characteristics as a function of light intensity appear to be sample-dependent. The lack of consensus on the electrical behavior of CIGS cells versus illuminance is also found in the literature^{5,6,13,14}. This will be discussed in section V.

IV. FITTING IV CURVES WITH THE COLLECTION FUNCTION

To get rid of the light dependence of the electrical parameters, we propose to model the DC electrical response of the thin film cells in a different way. Instead of fitting all the IV curves measured for each illuminance separately, we first extract the main characteristics from the IV curves, which we then fit as a function of illuminance as a whole. To do this, we measure the short-circuit current I_{sc} , the open-circuit voltage V_{oc} , the maximum power P_{max} , the fill factor $FF = P_{max}/(V_{oc} \times I_{sc})$, and the inverse slopes R_{sc} and R_{oc} at the short-circuit and open-circuit operating points respectively. These values are extracted directly from the IV curves without any prior assumptions. Figure 3(a-d) shows the dependencies of four of these parameters as a function of I_{sc} for 8 CIGS cells with a common GGI ratio of 0.28 and different CGI values indicated in the subplot (c). In short, we observe that the open-circuit voltage, which drops sharply with I_{sc} and cancels out for the copper-rich cells (purple-blue curves), remains above 0.2 V for the lowest CGI cell at 50 lx, i.e. $I_{sc} \sim 1 \mu A$ (orange-red curves). The fill factor also increases from 25 % for $CGI = 0.94$ to 50 – 60 % for $CGI = 0.46$ over the full illumination range. Figure 3(c) presents a strong increase in R_{sc} at low illuminance of more than three orders of magnitude as the copper content decreases. The short-circuit resistance jumps from 300 Ω at $CGI = 0.94$ to 600 k Ω at $CGI = 0.46$. All of these effects lead to a drastic enhancement of P_{max} , with a factor of 1000 increase at 50 lux between the copper-rich and copper-poor cells, as indicated by the vertical up arrow in subplot (d) of Fig. 3.

To fit these data, we now assume that the four parameters of the basic electrical circuit, namely I_0 , n , R_s and R_{sh} , are independent of illuminance and that all the light-dependent physical mechanisms are integrated into an additional term, which is the classical collection function. This contribution, which is ignored in the single-diode electrical model previously used to fit the IV curves (solid lines in Fig. 1), has been intensively studied in the past^{8,9}. It is represented either as a subtractive term describing the recombination current¹⁰ or as the fraction of the photogenerated current that is actually extracted from the cell. Many theoretical expressions of the voltage dependence of the collection function are reported in the literature^{11,15}, but here we decide to use the experimental data directly. For this purpose, the IV curves measured at different illuminances (46, 35, 23.5, 11.8 and 5.8 klx) were used to calculate the normalized collection function, $\eta(V) = (I_1(V) - I_2(V))/(I_{1sc} - I_{2sc})$, where the index 1 corresponds to the highest illuminance and the index 2 to the lower illuminances. The collection functions of the three same samples presented in Fig. 2 are plotted in Fig. 4(a), where different symbols are used for the different illuminances. The superposition of the data demonstrates that a single experimental collection function η allows to take into account all the light-dependent mech-

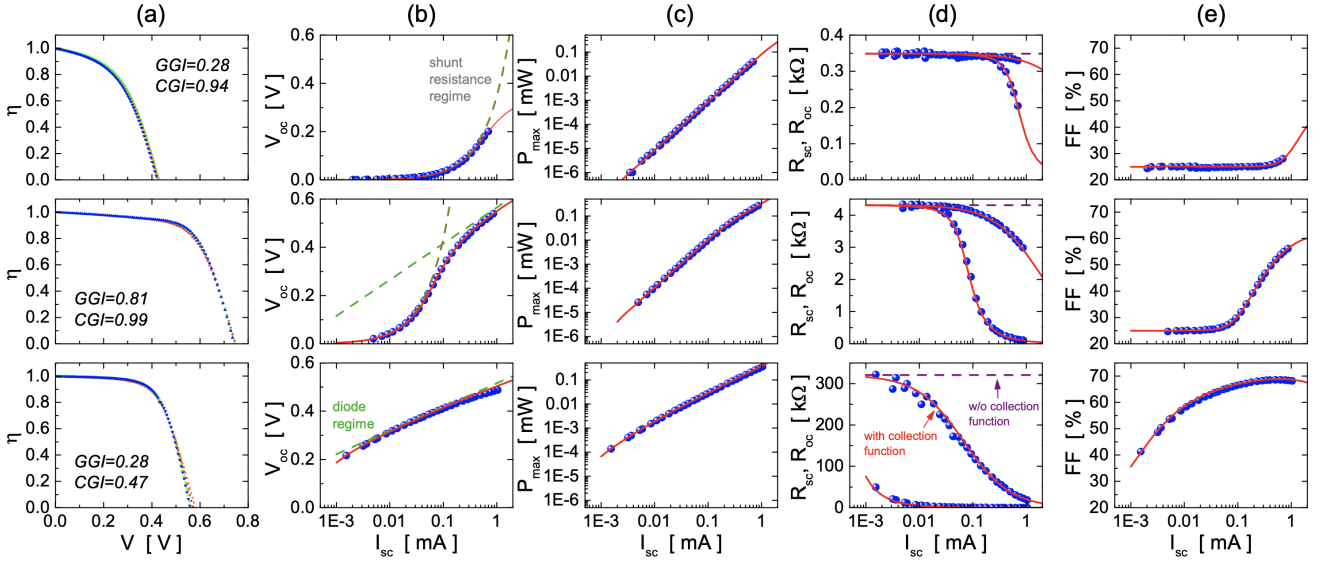


FIG. 4. The experimental collection function (column (a)), open-circuit voltage (b), maximum power (c), short-circuit and open-circuit resistances (d), and fill factor (e) are plotted vs the short circuit current for three different cells (one per row). The GGI and CGI ratios are given in subplots (a). The red solid lines in graphs (b-e) result from fits by the equivalent dc electrical circuit model improved by the experimental collection function, plotted in (a). The dashed lines in the V_{oc} graphs show the shunt resistance and diode contributions. The horizontal dashed lines in the R_{sc} graphs are the constant slopes vs I_{ph} when the collection function is neglected.

anisms independent of the light intensity. By adding the collection function to the single-diode electrical model, the voltage dependence of the current of the photovoltaic cell is written as follows:

$$I = \eta(V)I_{ph} - I_0 \left[\exp\left(\frac{q(V + R_s I)}{nk_B T}\right) - 1 \right] - \frac{V + R_s I}{R_{sh}} \quad (1)$$

Computing this equation for many photogenerated current values allows the IV characteristics to be simulated at any illumination level. Figures 4(b-e) show the experimental points (blue dots) and their respective fits (red solid lines), which show a very good agreement for all measured data over almost three orders of magnitude of illuminance with a single data set of electrical parameters (I_0 , n , R_s and R_{sh}) for each sample. We observe that when the shunt resistance is small and bypasses the diode (top row of Fig. 4), the current flows primarily through it. This resistance regime leads to linear IV curves, and V_{oc} is proportional to I_{sc} , as illustrated by the gray dashed curve (the logarithmic scale for I_{sc} makes the linear dependence look exponential). The slopes of the linear IV curves at the short-circuit and open-circuit points are obviously equal, hence the constant R_{sc} and R_{oc} in subplot (d). The fill factor equals 25 % since both the current and voltage at the maximum power are half of I_{sc} and V_{oc} . For an intermediate shunt resistance value (middle row in Fig. 4), the contribution of the diode increases so that the open-circuit voltage depends on the logarithm of I_{sc} , i.e. $V_{oc} \approx \frac{nk_B T}{q} \log(I_{sc}/I_0)$. At low light levels, the IV curves are still linear and $V_{oc} \propto I_{sc}$. This competition between

the shunt resistance and the diode leads to two regimes at low and high illuminances, which are clearly visible for the $GGI = 0.81$ and $CGI = 0.99$ cell. This is accompanied by a decrease in R_{sc} and R_{oc} towards the series resistance R_s at high illuminance^{10,16}. Also, the nonlinear IV characteristics cause the fill factor to become much higher than 25 %. Finally, when the shunt resistance is greater than several hundred kΩ, the internal current is negligible and the PV cell is reduced to a diode. In this regime, the open-circuit voltage decreases as $\log(I_{sc})$ ¹⁷ and the open-circuit resistance is almost equal to R_s (last row of graphs in Fig. 4). It is interesting to evaluate the influence of the collection function on the illuminance dependence of the short-circuit resistance. By neglecting this term, R_{sc} remains constant over the whole I_{sc} range (purple dashed line in Fig. 4(d)), while the model including the experimental collection function fits the R_{sc} data perfectly. It also suggests that when the IV curves are fitted individually without the collection function, as in the previous section, the effects are partially transferred to the illuminance dependence of R_{sh} .

V. DISCUSSION

Figure 5 (a) displays the shunt resistance for the three GGI batches with different CGI values. It is evident that reducing the copper content in the CIGS layer from $CGI = 1$ to 0.5 leads to an exponential increase of R_{sh} up to several hundred kΩ. The dependence of the shunt resistance on copper can be approximated by

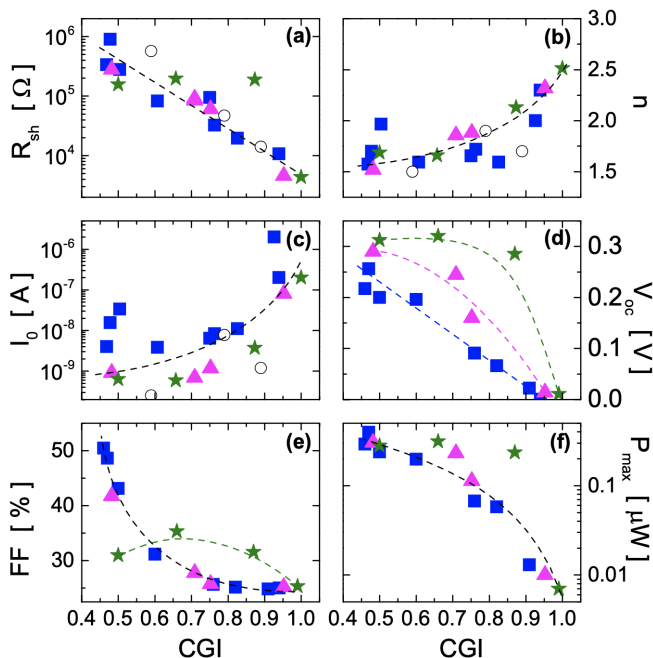


FIG. 5. Fitting parameters from the illuminance dependence of the IV curves vs the CGI ratio for the three cell series with GGI ratios equal to 0.28, 0.64 and 0.81 (square, triangle and star symbols respectively) : (a) R_{sh} , (b) n and (c) I_0 . The open circles are from Ref.⁵. The open circuit voltage (d), fill factor (e) and maximum power (f) measured for an illuminance of 100 lx. Dashed lines are guides for the eyes.

$R_{sh} \approx 4 \times 10^7 \exp(-9 CGI)^7$. We emphasize that the cells fabricated with lower CGI ratios of 0.3–0.4 were all short-circuited, preventing the evaluation of the electrical parameters at such low copper compositions. This suggests that a CGI of 0.5 is the optimum for the highest R_{sh} in single-stage CIGS thin films. The diode parameters n and I_0 plotted in Figs. 5(b) and (c) decrease slightly with decreasing copper composition against all odds. Indeed, this could indicate a better p-n junction and a reduction of the recombination centers with the increasing number of copper vacancies, which is highly unlikely. However, the reduction of the copper content leads to the formation of ordered vacancy compounds, which cause such significant changes in the absorber layer (doping concentration, defects, crystalline quality, band gap and offset) that it is difficult to model their impact on the diode specifications. Finally, we observe that the data measured in the dark by Virtuani *et al.*⁶ (open circles in Figs. 5(a-c)) are in good agreement with our results, but the wider range of CGI in our study allows the observation of general trends that were not clearly identified before.

To illustrate the beneficial influence of a high shunt resistance on the IV curves at very low illuminance, we have plotted the V_{oc} , FF , and P_{max} values measured under 100 lx white LED illumination in Fig. 5(d-f). The open circuit voltage takes advantage of the higher R_{sh} with a value of 0.25–0.3 V at 100 lx for all gallium com-

positions, while it is insignificant for copper-rich cells. The fill factor also doubles passing from 25 % to 50 % for the $GGI = 0.28$ and 0.64 series. As a consequence the maximum power is obtained for the CGI range from 0.45 to 0.5, whatever the GGI ratio, with a value of $\sim 1.5 \mu W/cm^2$. Note that the $CGI = 0.94$ data shown in Fig. 3 (purple dots) with a shunt resistance of 350 Ω and a maximum power of 1.5 nW/cm^2 are not shown in Figs. 5(a) and (f) to maintain reasonable scale. However, considering these data, when the copper content in the CIGS absorber is reduced from 1 to 0.5, the shunt resistance and the maximum power at low illuminance are increased by three orders of magnitude.

We now discuss the differences between our two approaches. It is evident that our second original fitting method allows the extraction of single electrical parameters that are valid over a wide range of illuminances, assuming that the collection function includes all the light-dependent physical mechanisms that occur in the cell. The advantage of this method is that the individual characteristics can be easily compared between the PV devices. On the other hand, the standard fitting of IV curves vs illuminance by the single-diode model results in light-dependent parameters, that are also sample-dependent. In this case, the comparison of the parameters is more difficult. In Fig. 2, two different devices may have similar values at one illuminance, but different values at another illuminance. The previous reports on the light dependence of the electrical parameters in CIGS thin films, obtained from the single IV curve fitting method, also lead to controversial light dependence of the electrical parameters^{5,6,13,14}. For example, Virtuani *et al.*⁶ reported an increase of the shunt resistance from 1.9 $k\Omega cm^2$ under 1 sun to 142 $k\Omega cm^2$ in the dark, as well as an increase of the series resistance, which was attributed to the photoconductivity effect in the absorber. At the same time, the I_0 and n parameters were shown not to vary significantly from 0.1 to 100 mW/cm^2 ²⁵. Similarly, Bronzoni *et al.* reported that I_0 , n and R_s do not change much as a function of light conditions, but R_{sh} increases inversely proportional to irradiance in the range 30–130 mW/cm^2 ¹³. More recently, the work of Ramesh *et al.* concludes that shunt resistance and reverse current increase as a power law of decreasing irradiance in the range of 100–1200 W/m^2 , with an empirical coefficient between -1 and -0.4 for R_{sh} and -0.24 and -0.13 for I_0 ¹⁴. The series resistance does not vary. In conclusion, we see that the variation of the electrical quantities I_0 , n and R_s as a function of the light level is often weak, whereas a common trend is observed for the shunt resistance, which reveals a significant increase when the illuminance is lower. This is consistent with our data in Fig. 2(d), where the light dependence is embodied by the R_{sh} , or in Fig. 4 where the light-independent shunt value is compensated by the collection function.

VI. CONCLUSION

We demonstrate that the shunt resistance of CIGS photovoltaic cells increases exponentially as the copper composition of the alloy, $CGI = [Cu]/([Ga]+[In])$ decreases from 1 to 0.45, regardless of the gallium ratio between 0.28 and 0.81. This result is obtained by means of an unusual fitting procedure based on a light-independent electrical model of the cell, coupled with the collection function, which allows a perfect agreement of the illumination dependence of the IV characteristics over three orders of magnitude. Our work suggests that a CIGS absorber with a CGI ratio of 0.5 is electrically optimal for single-step Cu(In,Ga)Se₂-based indoor PV devices.

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DATA AVAILABILITY STATEMENT

Data is available on request from the authors.

CONFLICTS OF INTERESTS

The authors declare no conflict of interest.

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